

Notice of References Cited	Application/Control No. 10/517,377		Applicant(s)/Patent Under Reexamination FURUTA ET AL.	
	Examiner IAN JEN		Art Unit 3664	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	C	US-6,377,014 B1	04-2002	Gomi et al.	318/568.12
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NON-PATENT DOCUMENTS

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